

FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT BY APPLICANT	ATTY. DOCKET NO. MIC-20		APPLN. NO.
	APPLICANT Pary Baluswamy et al.		
	FILING DATE Herewith	GROUP AR ¹⁷⁵⁶ 10/10/0073 S. PRO 03/01/02	

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
SPM	5,932,491	8/1999	Wald et al.	438	734	
SPM	6,120,952	9/2000	Pierrat et al.	430	30	
SPM	6,144,109	11/2000	Stanton et al.	257	797	
SPM	6,214,497	4/2001	Stanton	430	5	
SPM	6,238,824	5/2001	Futrell et al.	430	5	
SPM	6,242,816	6/2001	Stanton et al.	257	797	
SPM	6,245,468	7/2001	Futrell et al.	430	5	
SPM	6,258,489	7/2001	Stanton et al.	430	5	
SPM	6,284,419	9/2001	Pierrat et al.	430	30	
SPM	6,319,644	11/2001	Pierrat et al.	430	30	
SPM	2001/0002304A1	5/2001	Pierrat et al.	430	30	
SPM	2001/0023043A1	9/2001	Futrell et al.	430	5	
SPM	2001/0023045A1	9/2001	Pierrat et al.	430	30	
SPM	2001/0033979A1	10/2001	Baggenstoss	430	5	

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER INITIAL	[REDACTED]
SPM	Peterson, J.S., "Analytical Description of Anti-scattering and Scattering Bar Assist Features," Proceedings of SPIE: Optical Microlithography XIII, vol. 4000, pp. 77-89 (March 1-3, 2000)

EXAMINER Mohamedulla

DATE CONSIDERED 3/3/04

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not conformance and not considered. Include copy of this form with next communication to applicant.